

Notice of References Cited	Application/Control No. 10/734,047	Applicant(s)/Patent Under Reexamination KWON, HYUK TARK	
	Examiner Jeff Wollschlager	Art Unit 1732	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,284,171	09-2001	Nonomura et al.	264/40.3
*	B	US-5,229,043	07-1993	Lee, Ron C.	264/37.16
*	C	US-3,450,805	06-1969	CHESSER JOHN F	264/28
*	D	US-2004/0161623	08-2004	Domine et al.	428/515
*	E	US-2002/0055006	05-2002	Vogel et al.	428/520
*	F	US-2002/0114965	08-2002	Horansky, John	428/520
*	G	US-3,819,792	06-1974	Katsuya et al.	264/515
*	H	US-3,233,416	02-1966	RAINWATER JEWEL G; et. al.	62/5
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.